Application/Control No. Applicant(s)/Patent Under Reexamination 09/990,823 **AKLILU ET AL.** Notice of References Cited Art Unit Examiner Page 1 of 1 Nitin C. Patel 2116 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 324/207.22 02-2003 Haupt et al. US-6,522,133 Α 714/15 08-2002 Shinichi et al. US-6,438,708 В 713/2 US-2001/0039612 11-2001 Lee, Sang-Jin C 713/300 US-6,266,776 07-2001 Sakai, Makoto D 713/320 01-2004 US-6,678,831 Mustafa et al. Ε 711/162 08-2000 US-6,098,158° Lay et al. F 08-2001 US-2001/0016918 Alexander et al. 713/323 G 07-2004 713/320 US-6,760,850 Atkinson et al. Н US-6,721,885 713/2 04-2004 Freeman et al. 08-2002 Kang, Seong-Cheol 713/2 US-6,434,696 J 06-2001 Noehring et al. 701/113 US-6,249,739 K Stevens et al. 05-2001 713/320 US-6,230,274 L US-6,636,963 10-2003 713/1 Stein et al. М **FOREIGN PATENT DOCUMENTS Document Number** Date Classification Country Name MM-YYYY **Country Code-Number-Kind Code** Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W X

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.